


<b>Search Notes</b> 	<b>Application/Control No.</b> 10582006	<b>Applicant(s)/Patent Under Reexamination</b> LAI ET AL.
	<b>Examiner</b> Mary E Mosher, Ph.D.	<b>Art Unit</b> 1648

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST USPat PGPub EPO JPO Derwent, see printout	9/11/08	MM
SEQ 3,5,7,11,13,15, see SCORE	8/8/08	STIC
Dialog 155, 357, see printouts	9/11/08	MM
inventor search	"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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